## **Notice of References Cited**

	1		
Application/Control No.		Applicant(s)/Pate	nt Under
09/499,693		Reexamination LEE ET AL.	
Examiner		Art Unit	
Lauren Q Wells		1617	Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5681608	10-1997	Cain et al.	426/606
	В	US-6103276	08-2000	Pilgrim et al.	426/2
	С	US-4752618	06-1988	Mascioli et al.	514/549
	D	US-4863753	09-1989	Hunter et al.	426/633
	Ε	US-5416114	05-1995	Yehuda	514/560
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	61085143	04-1986	JP	Harumi et al.	
	0	01187256	03-1991	JP	Yukihisa et al.	
	Р	211502	02-1987	EP	Horrobin	
	Q	04046998	02-1992	JP		
	R				•	
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.